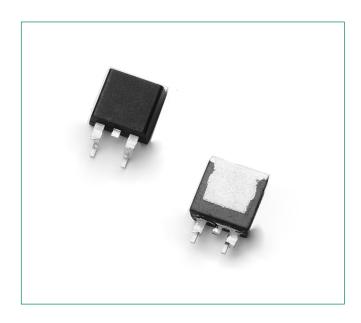


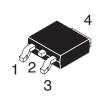
## Surface Mount - 600V - 800V > MCR8DSM, MCR8DSN

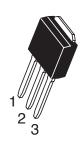
# MCR8DSM, MCR8DSN





#### **Pin Out**





#### **Description**

Designed for high volume, low cost, industrial and consumer applications such as motor control; process control; temperature, light and speed control.

#### **Features**

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Available in Two Package Styles
   Surface Mount Lead Form Case 369C
   Miniature Plastic Package Straight Leads Case 369
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V
   Machine Model, C > 400 V
- Pb-Free Packages are Available

## **Functional Diagram**



#### **Additional Information**









## **Maximum Ratings** $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1)  (– 40 to 1125°C, Sine Wave, 50 to 60 Hz, Gate Open)  MCR8DSM  MCR8DSN	V <sub>DRM</sub> , V <sub>RRM</sub>	600 800	V
On-State RMS Current (All Conduction Angles; $T_c = 90$ °C)	I <sub>T (RMS)</sub>	8.0	А
Average On–State Current (180° Conduction Angles; T <sub>c</sub> = 90°C)	I <sub>T(AV)</sub>	5.1	А
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, TJ = 110°C)	I <sub>TSM</sub>	60	А
Circuit Fusing Consideration (t = 8.3 ms)	l²t	34	A <sup>2</sup> sec
Forward Peak Gate Power (Pulse Width $\leq$ 10 $\mu$ sec, $T_c = 90^{\circ}$ C)	P <sub>GM</sub>	5.0	W
Forward Average Gate Power (t = 8.3 msec, $T_c = 90$ °C)	P <sub>GM (AV)</sub>	0.5	W
Forward Peak Gate Current (Pulse Width $\leq 1.0 \mu sec$ , $T_{c} = 90^{\circ}C$ )	I <sub>GM</sub>	2.0	А
Operating Junction Temperature Range	Т	-40 to 110	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### **Thermal Characteristics**

Rating	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R <sub>sJC</sub>	2.2	
Thermal Resistance, Junction-to-Ambient	R <sub>8JA</sub>	88	°C/W
Thermal Resistance, Junction-to-Ambient (Note 2)	R <sub>8JA</sub>	80	
Maximum Device Temperature for Soldering Purposes (Note 3)	T <sub>L</sub>	260	°C

<sup>1.</sup> V<sub>DBM</sub> and V<sub>BBM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

# **Thyristors**

### **Electrical Characteristics** - **OFF** (T<sub>1</sub> = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
Peak Repetitive Forward or Reverse Blocking Current	T <sub>J</sub> = 25°C	l <sub>DRM</sub> ,	-	-	10	uA
(Note 3) ( $V_{AK} = Rated V_{DRM} \text{ or } V_{RRM}, R_{GK} = 1.0 \text{ k}\Omega$	$T_J = 110^{\circ}C$	I <sub>RRM</sub>	-	-	500	μΑ

## **Electrical Characteristics** - **ON** (T<sub>J</sub> = 25°C unless otherwise noted; Electricals apply in both directions)

Characteristic	Symbol	Min	Тур	Max	Unit
Peak Reverse Gate Blocking Voltage ( $I_{GR} = 10 \mu A$ )	V <sub>GRM</sub>	10	12.5	18	V
Peak Reverse Gate Blocking Current (V <sub>GR</sub> = 10 V)	I <sub>RGM</sub>	-	-	1.2	μА
Peak Forward On–State Voltage (Note 4) ( $I_{TM} = 16 \text{ A}$ )	V <sub>TM</sub>	_	1.4	1.8	V
Gate Trigger Current (Continuous dc) (Note 5) $(V_{AK}=12~Vdc,~R_{L}=100~\Omega) \\ (T_{J}=25^{\circ}C) \\ (T_{J}=-40^{\circ}C)$	I <sub>GT</sub>	5.0 –	12 -	200 300	μΑ
Gate Trigger Voltage (Continuous dc) ( $V_D = 12 \text{ V}$ , $R_L = 100 \Omega$ ) ( $V_D = 12 \text{ V}$ , $R_L = 100 \Omega$ ) (Note 5) ( $V_D = 12 \text{ V}$ , $V_D$		0.45 - 0.2	0.65 - -	1.0 1.5	V
Holding Current (V $_{\rm D}$ = 12 V, Initiating Current = 200 mA, R $_{\rm GK}$ = 1 kΩ) (T $_{\rm J}$ = 25°C) (T $_{\rm J}$ = $-40^{\circ}$ C)		0.5	1.0	6.0 10	mA
Latching Current $(T_J = 25^{\circ}\text{C})$ $(V_D = 12 \text{ V, IG} = 2.0 \text{ mA, R}_{GK} = 1 \text{ k}\Omega)$ $(T_J = -40^{\circ}\text{C})$	I <sub>L</sub>	0.5	1.0	6.0 10	mA
Total Turn–On Time (Source Voltage = 12 V, $R_s$ = 6.0 k $\Omega$ , IT = 16 A(pk), $R_{gK}$ = 1.0 k $\Omega$ ) (VD = Rated $V_{DRM}$ , Rise Time = 20 ns, Pulse Width = 10 $\mu$ s)	tgt	-	2.0	5.0	μs

#### **Dynamic Characteristics**

Characteristic	Symbol	Min	Тур	Max	Unit
Critical Rate of Rise of Off–State Voltage ( $V_D = 0.67 \text{ X Rated V}_{DRM}$ , Exponential Waveform, $R_{GK} = 1.0 \text{ k}\Omega$ , $T_J = 110 ^{\circ}\text{C}$ )	dv/dt	2.0	10	-	V/µs

<sup>2.</sup> Surface mounted on minimum recommended pad size.

<sup>3.</sup> Ratings apply for negative gate voltage or RGK = 1.0 kQ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.

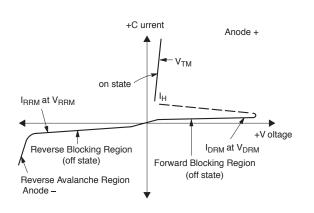
<sup>4.</sup> Pulse Test; Pulse Width  $\leq$  2.0 msec, Duty Cycle  $\leq$  2%.

<sup>5.</sup> RGK current not included in measurements.



### **Voltage Current Characteristic of SCR**

Symbol	Parameter
$V_{DRM}$	Peak Repetitive Forward Off State Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
V <sub>RRM</sub>	Peak Repetitive Reverse Off State Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
V <sub>TM</sub>	Maximum On State Voltage
I <sub>H</sub>	Holding Current



**Figure 1. Average Current Derating** 

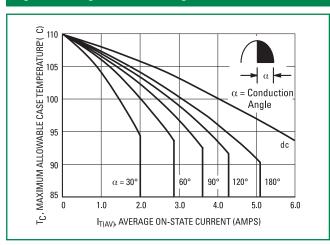


Figure 2. On-State Power Dissipation

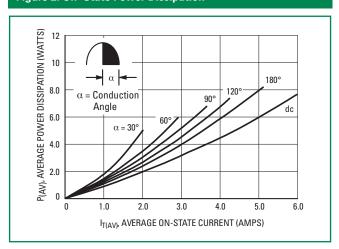


Figure 3. On-State Characteristics

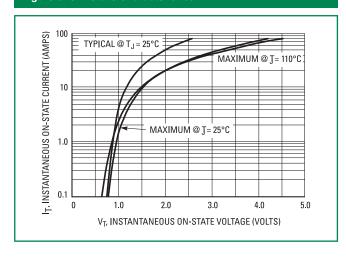


Figure 4. Transient Thermal Response

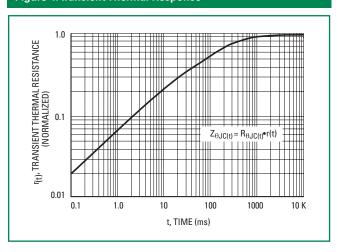




Figure 5. Typical Gate Trigger Current vs Junction Temperature

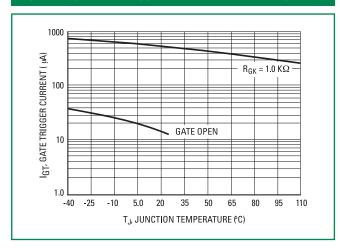


Figure 6. Typical Gate Trigger Voltage vs Junction Temperature

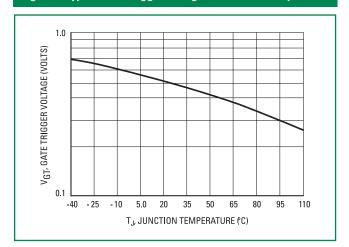


Figure 7. Typical Holding Current vs Junction Temperature

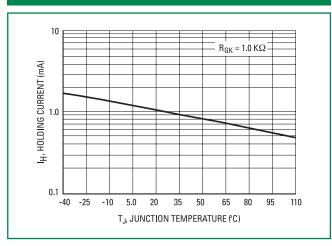


Figure 8. Typical Latching Current vs Junction Temperature

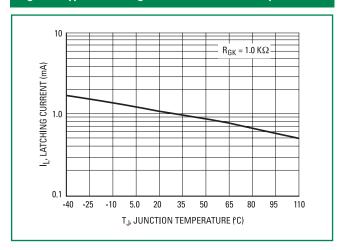


Figure 9. Holding Current versus Gate-Cathode Resistance

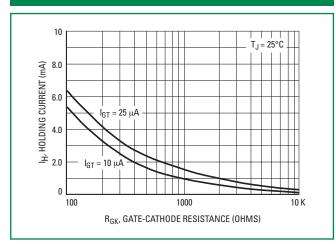


Figure 10. Exponential Static dv/dt vs Gate-Cathode Resistance and Junction Temperature

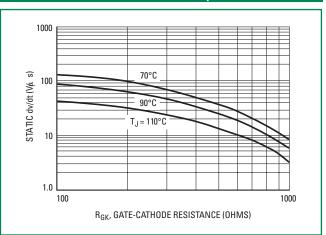




Figure 11. Exponential Static dv/dt vs Gate-Cathode Resistance and Peak Voltage

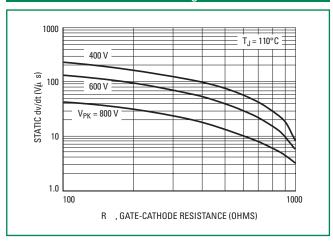
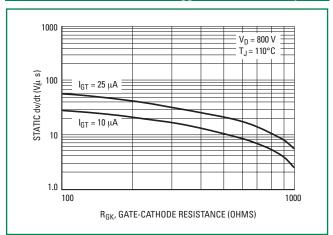
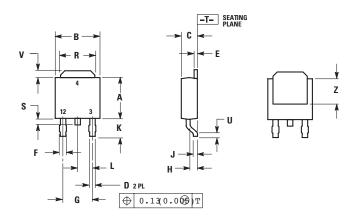


Figure 12. Exponential Static dv/dt vs Gate-Cathode Resistance and Gate Trigger Current Sensitivity



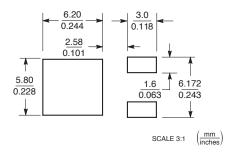
#### **Dimensions**



5.	Inches		Millim	eters	
Dim	Min	Max	Min	Max	
А	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.180 BSC		4.58 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.102	0.114	2.60	2.89	
L	0.090 BSC		2.29 BSC		
R	0.180	0.215	4.57	5.45	
S	0.025	0.040	0.63	1.01	
U	0.020		0.51		
V	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.

### **Soldering Footprint**



#### **Part Marking System**



Pin Assignment				
1	Cathode			
2	Anode			
3	Gate			
4	Anode			

#### **Ordering Information**

Device	Package	Shipping
MCR8DSMT4	DPAK	
MCR8DSMT4G	DPAK (Pb-Free)	2500/Tape & Reel
MCR8DSNT4	DPAK	2300/Tape & Heer
MCR8DSNT4G	DPAK (Pb-Free)	

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TD250N16KOF-A VS-ST110S16P0 VS-10RIA10 VS-16TTS08-M3 TS110-7A1-AP T930N36TOF VT T2160N24TOF VT